TOSHIBA PhotoInterrupter Infrared LED + Phototransistor

TLP831(F)

Lead(Pb)-Free

Home Electronics Equipment Such As VCRS And CD Players

OA Equipment Such As Copiers, Printers, And Facsimiles

Automatic Servicing Equipment Various Position Detection Sensor

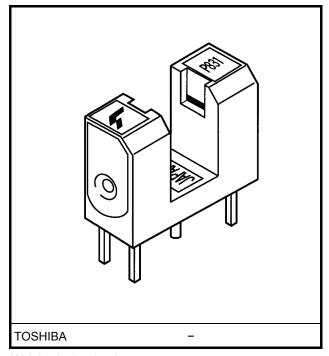
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The TLP831(F) photointerrupter consists of a high radiant power GaAs infrared LED and a Si phototransistor.

Housed in a short lead package, this device is ideal for automatic mounting.

- Printed wiring board direct mounting type (with a locating pin)
- Short lead type enabling automatic mounting : Lead length 3.4 ± 0.3 mm
- Board thickness: 1.6mm or less
- Gap: 4.2mm
- Resolution: Slit width 0.5mm
- High current transfer ratio: $I_C / I_F = 5\%$ (min)
- High response speed: t_r , $t_f = 15\mu s$ (typ.)
- Detector side is of visible light cut type.
- Material of the package

: Polybutylene terephthalate (UL94V-0, black color)



Weight: 0.58 g (typ.)



Absolute Maximum Ratings (Ta = 25°C)

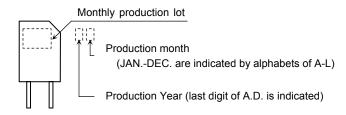
Characteristic		Symbol	Rating	Unit	
TED	Forward current	lF	50	mA	
	Forward current derating (Ta > 25°C)	ΔI _F / °C	-0.33	mA / °C	
	Reverse voltage	V _R	5	V	
moorl Detector	Collector-emitter voltage	V _{CEO}	35	V	
	Emitter-collector voltage	V _{ECO}	5	٧	
	Collector power dissipation	PC	75	mW	
	Collector power dissipation derating (Ta > 25°C)	ΔP _C / °C	-1	mW / °C	
	Collector current	IC	50	mA	
Operating temperature		T _{opr}	-30~85	°C	
Storage temperature		T _{stg}	−40~100	°C	
Soldering temperature (5 s) (Note 1)		T _{sol}	260	°C	

Note: Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 1: At the location of 1.5mm from the resin package bottom

Product Indication



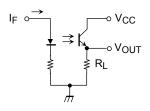
Operating Ranges

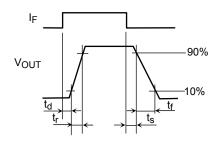
Characteristic	Symbol	Min.	Тур.	Max.	Unit
Supply voltage	V _{CC}	_	5	24	V
Forward current	lF	_	_	25	mA
Operating temperature	T _{opr}	-10	_	75	°C

Opto Electrical Characteristics (Ta = 25°C)

Characteristic		Symbol	Test Condition	Min.	Тур.	Max.	Unit
LED	Forward voltage	V _F	I _F = 10mA	1.00	1.15	1.30	V
	Reverse current	I _R	V _R = 5V	_	_	10	μA
	Peak emission wavelength	λР	I _F = 10mA	_	940	_	nm
Detector	Dark current	ID (ICEO)	V _{CE} = 24V, I _F = 0	_	_	0.1	μΑ
	Peak sensitivity wavelength	λР		-	870	-	nm
Coupled	Current transfer ratio	I _C / I _F	V _{CE} = 2V, I _F = 10mA	5	_	100	%
	Collector–emitter saturation voltage	V _{CE (sat)}	I _F = 20mA, I _C = 0.5mA	_	0.1	0.35	V
	Rise time	t _r	V_{CC} = 5V, I _C = 1mA R _L = 1k Ω (Note 2)	_	15	50	116
	Fall time	t _f		-	15	50	μs

Note 2: Switching time measurement circuit and waveform





Precautions

- When removing flux with chemicals after soldering, clean only the leads on the soldering side; do not dip the whole package for cleaning.
 - Chemicals remaining on a surface of LED or phototransistor, if any, would have a bad influence to the optical characteristics and it may severely lower the conversion efficiency.
- The environment to install the device should be determined carefully. Oil or chemicals may cause the package to be dissolved or cracked.
- The device should be mounted on an unwrapped surface.
- Install this device as avoiding the disturbance light as possible. A visible light cut-off type phototransistor which blocks light with frequencies of 700nm or above is used. However, the device cannot block infrared light with a wavelength of 700nm or more, and it may do mistaken movements.
- Conversion efficiency falls over time due to the current which flows in the infrared LED. When designing a circuit, take into account this change in conversion efficiency over time. The ratio of fluctuation in conversion efficiency to fluctuation in infrared LED optical output is 1:1.

$$\frac{I_{C} / I_{F}(t)}{I_{C} / I_{F}(0)} = \frac{P_{O}(t)}{P_{O}(0)}$$

Tolerant

Differences

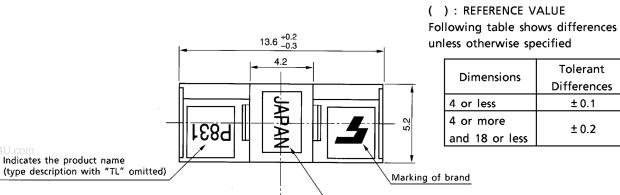
± 0.1

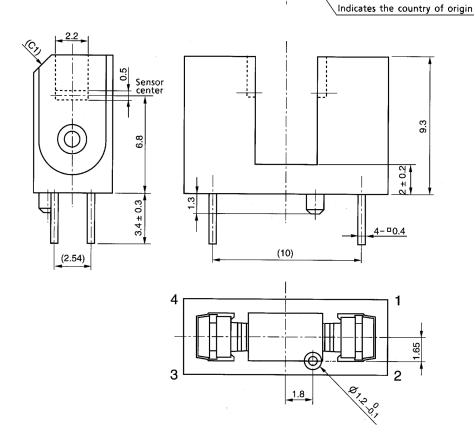
± 0.2

Unit: mm

Dimensions

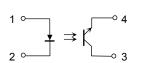
Outline: TOSHIBA



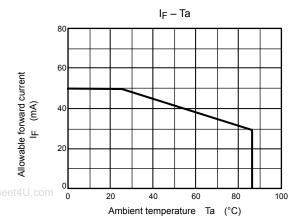


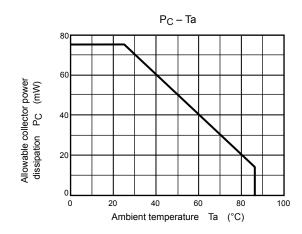
Weight: 0.58 g (typ.)

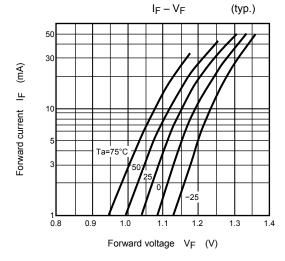
Pin Connection

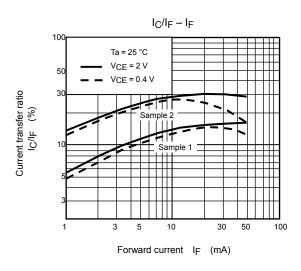


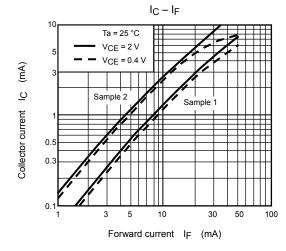
- 1. Anode
- 2. Cathode
- 3. Collector
- 4. Emitter

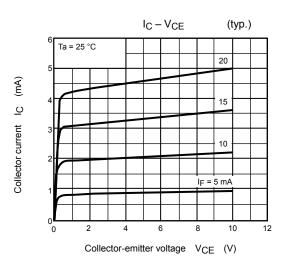


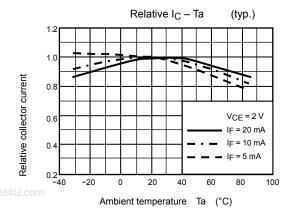


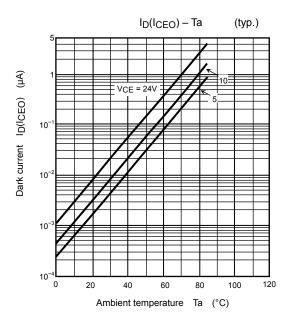


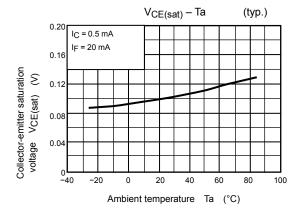


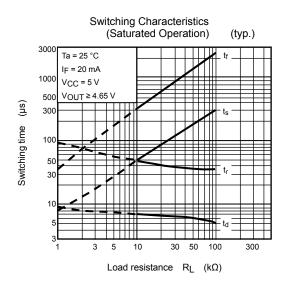


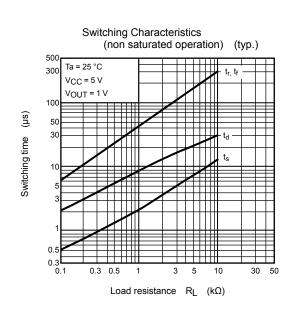


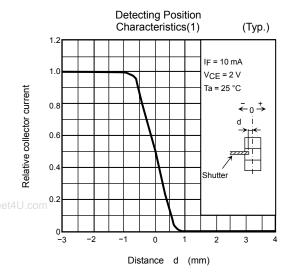


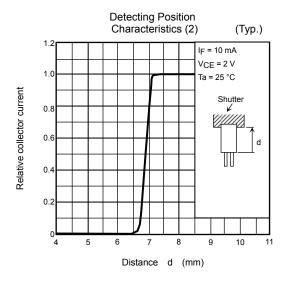












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RESTRICTIONS ON PRODUCT USE

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